

## SANYO Semiconductors DATA SHEET

N-Channel Silicon MOSFET

# **FSS804** — General-Purpose Switching Device **Applications**

#### **Features**

- · Low ON-resistance.
- · 4V drive.

#### **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		30	V
Gate-to-Source Voltage	VGSS		±20	V
Drain Current (DC)	ID		14	Α
Drain Current (PW≤10s)	ID	Duty cycle≤1%	18	Α
Drain Current (PW≤10μs)	IDP	Duty cycle≤1%	52	Α
Allowable Power Dissipation	PD	Mounted on a ceramic board (1200mm²X0.8mm), PW≤10s	3.3	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

#### Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			l loit
			min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=1mA, VGS=0V	30			V
Zero-Gate Voltage Drain Current	IDSS	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μΑ
Gate-to-Source Leakage Current	IGSS	V <sub>GS</sub> =±16V, V <sub>DS</sub> =0V			±10	μΑ
Cutoff Voltage	VGS(off)	VDS=10V, ID=1mA	1.2		2.6	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> =10V, I <sub>D</sub> =14A	11.5	19		S
Static Drain-to-Source On-State Resistance	R <sub>DS</sub> (on)1	I <sub>D</sub> =14A, V <sub>GS</sub> =10V		7	10	mΩ
	RDS(on)2	ID=7A, VGS=4.5V		11	16	mΩ
	RDS(on)3	I <sub>D</sub> =7A, V <sub>G</sub> S=4V		14	20	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> =10V, f=1MHz		3000		pF
Output Capacitance	Coss	V <sub>DS</sub> =10V, f=1MHz		500		pF
Reverse Transfer Capacitance	Crss	V <sub>DS</sub> =10V, f=1MHz		350		pF
Turn-ON Delay Time	td(on)	See specified Test Circuit.		28		ns
Rise Time	t <sub>r</sub>	See specified Test Circuit.		250		ns
Turn-OFF Delay Time	t <sub>d</sub> (off)	See specified Test Circuit.		160		ns
Fall Time	tf	See specified Test Circuit.		120		ns

Marking: S804 Continued on next page.

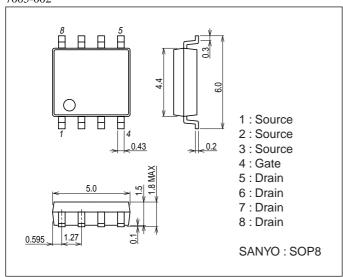
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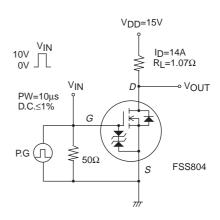
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Onit
Total Gate Charge	Qg	V <sub>DS</sub> =10V, V <sub>GS</sub> =10V, I <sub>D</sub> =14A		50		nC
Gate-to-Source Charge	Qgs	V <sub>DS</sub> =10V, V <sub>GS</sub> =10V, I <sub>D</sub> =14A		8		nC
Gate-to-Drain "Miller" Charge	Qgd	V <sub>DS</sub> =10V, V <sub>GS</sub> =10V, I <sub>D</sub> =14A		10		nC
Diode Forward Voltage	VSD	IS=14A, VGS=0V		0.81	1.2	V

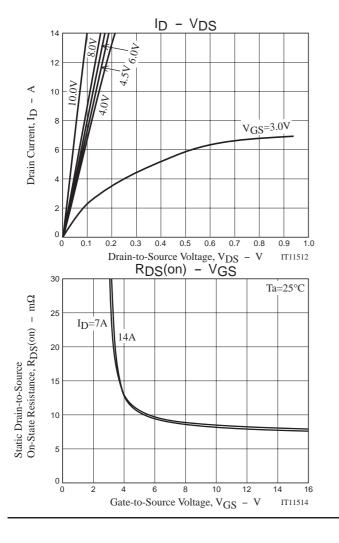
#### **Package Dimensions**

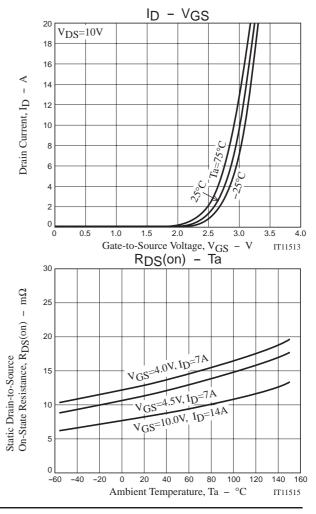
unit : mm (typ) 7005-002

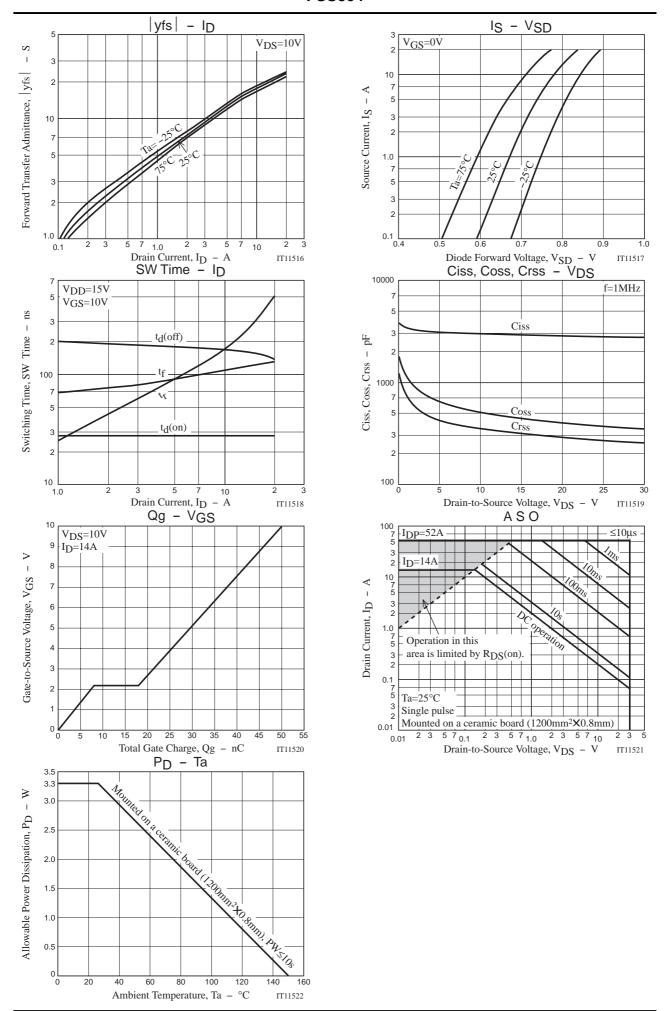


### **Switching Time Test Circuit**









Note on usage: Since the FSS804 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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